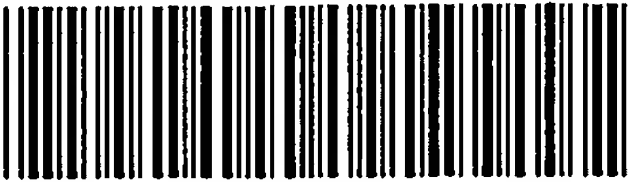


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/652,489	HWANG, IN-SU	
	Examiner	Art Unit	
	Geoffrey Mruk	2853	

SEARCHED			
Class	Subclass	Date	Examiner
347	7	6/10/2005	GM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Text search for radioactive, sensor, emitting, and light	6/10/2005	GM